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June 2014

# **FDMC8200**

# Dual N-Channel PowerTrench® MOSFET 30 V, 9.5 m $\Omega$ and 20 m $\Omega$

### **Features**

Q1: N-Channel

- Max  $r_{DS(on)} = 20 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 6 \text{ A}$
- Max  $r_{DS(on)}$  = 32 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 5 A

Q2: N-Channel

- Max  $r_{DS(on)} = 9.5 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 9 \text{ A}$
- Max  $r_{DS(on)}$  = 13.5 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 7 A
- RoHS Compliant

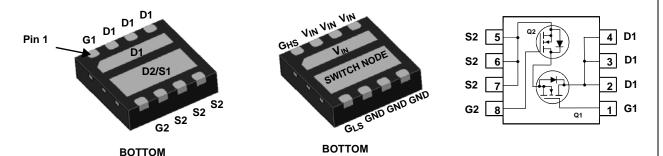


### **General Description**

This device includes two specialized N-Channel MOSFETs in a dual Power33 (3mm x 3mm MLP) package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous MOSFET (Q2) have been designed to provide optimal power efficiency.

### **Applications**

- Mobile Computing
- Mobile Internet Devices
- General Purpose Point of Load



Power 33

### MOSFET Maximum Ratings T<sub>C</sub> = 25 °C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units	
V <sub>DS</sub>	Drain to Source Voltage	Drain to Source Voltage		30	V	
$V_{GS}$	Gate to Source Voltage (Note 3)		±20	±20	V	
	Drain Current - Continuous (Package limited)	T <sub>C</sub> = 25 °C	18	18		
I <sub>D</sub>	- Continuous (Silicon limited)	T <sub>C</sub> = 25 °C	23	45	^	
	- Continuous	T <sub>A</sub> = 25 °C	8 <sup>1a</sup>	12 <sup>1b</sup>	A	
	- Pulsed		40	40		
В	Power Dissipation	T <sub>A</sub> = 25 °C	1.9 <sup>1a</sup>	2.2 <sup>1b</sup>	W	
$P_{D}$	Power Dissipation	T <sub>A</sub> = 25 °C	0.7 <sup>1c</sup>	0.9 <sup>1d</sup>	VV	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range -55 to +150				°C	

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	65 <sup>1a</sup>	55 <sup>1b</sup>	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient 180 <sup>1c</sup> 14			°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	7.5	4	,

### **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC8200	FDMC8200	Power 33	13 "	12 mm	3000 units

# **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted

Symbol	Parameter Test Conditions		Type	Min	Тур	Max	Units
Off Chara	cteristics						
BV <sub>DSS</sub>	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$ $I_D = 250 \mu A, V_{GS} = 0 V$	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 μA, referenced to 25 °C $I_D$ = 250 μA, referenced to 25 °C	Q1 Q2		14 14		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0 V	Q1 Q2			1 1	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	Q1 Q2			100 100	nA nA

### **On Characteristics**

V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	Q1	1.0	2.3	3.0	V
- GS(III)		$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	Q2	1.0	2.3	3.0	-
$\Delta V_{GS(th)}$	Gate to Source Threshold Voltage	I <sub>D</sub> = 250 μA, referenced to 25 °C	Q1		-5		mV/°C
$\Delta T_{J}$	Temperature Coefficient	$I_D = 250 \mu A$ , referenced to 25 °C	Q2		-6		IIIV/°C
	Static Drain to Source On Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6 A			16	20	
		$V_{GS} = 4.5 \text{ V}, I_D = 5 \text{ A}$	Q1		24	32	
r		$V_{GS} = 10 \text{ V}, I_D = 6 \text{ A}, T_J = 125 °C$			22	28	mΩ
r <sub>DS(on)</sub>		$V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}$			7.3	9.5	1115.2
		$V_{GS} = 4.5 \text{ V}, I_{D} = 7 \text{ A}$	Q2		9.5	13.5	
		$V_{GS} = 10 \text{ V}, I_D = 9 \text{ A}, T_J = 125 °C$			10	13	
~	Forward Transconductance	$V_{DD} = 5 \text{ V}, I_{D} = 6 \text{ A}$	Q1		29		S
9 <sub>FS</sub>		$V_{DD} = 5 \text{ V}, I_{D} = 9 \text{ A}$	Q2		56		3

# **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance		Q1 Q2	495 1180	660 1570	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHZ	Q1 Q2	145 330	195 440	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		Q1 Q2	20 30	30 45	pF
R <sub>g</sub>	Gate Resistance		Q1 Q2	1.4 1.4		Ω

# **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time	Q1		Q1 Q2	11 13	20 23	ns
t <sub>r</sub>	Rise Time		$V_{DD}$ = 15 V, $I_{D}$ = 1 A, $V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		3.1 4	10 10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	Q2 V <sub>DD</sub> = 15 V, I <sub>D</sub> = 1 A	Α	Q1 Q2	35 38	56 60	ns
t <sub>f</sub>	Fall Time		$V_{\text{DS}} = 10 \text{ V}, N_{\text{DE}} = 10 \text{ A},$ $V_{\text{GS}} = 10 \text{ V}, R_{\text{GEN}} = 6 \Omega$		1.3 6	10 12	ns
Q <sub>g(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V		Q1 Q2	7.3 16	10 22	nC
$Q_{g(TOT)}$	Total Gate Charge	V <sub>GS</sub> = 0 V to 4.5 V	$V_{DD} = 15 \text{ V},$ $I_{D} = 6 \text{ A},$	Q1 Q2	3.1 7	4.3 10	nC
Q <sub>gs</sub>	Gate to Source Charge		Q2: V <sub>DD</sub> = 15 V,	Q1 Q2	1.8 4.1		nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge		$I_D = 9 A$	Q1 Q2	1 1.5		nC

2

Max Units

# **Electrical Characteristics** $T_J = 25$ °C unless otherwise noted

Parameter

Drain-S	Drain-Source Diode Characteristics							
V	Source to Drain Diode Forward Volt-	$V_{GS} = 0 \text{ V}, I_{S} = 6 \text{ A}$	(Note 2)	Q1		0.8	1.2	\/
$V_{SD}$	age	$V_{GS} = 0 \text{ V}, I_S = 6 \text{ A}$ $V_{GS} = 0 \text{ V}, I_S = 9 \text{ A}$	(Note 2)	Q2		0.8	1.2	V
t <sub>rr</sub> Reverse Recovery Time	Poverse Recovery Time	Q1		Q1		13	24	no
	Reverse Recovery Time	$I_F = 6 \text{ A}, \text{ di/dt} = 100 \text{ A/s}$		Q2		21	34	ns
0	Reverse Recovery Charge	Q2		Q1		2.3	10	nC
$Q_{rr}$	Reverse Recovery Charge	$I_F = 9 A$ , $di/dt = 100 A/s$		Q2		5.6	12	iiC

**Test Conditions** 

#### Notes

Symbol

1.  $R_{\theta JA}$  is determined with the device mounted on a 1in<sup>2</sup> pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.65 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



b.55 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

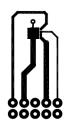
Туре

Min

Тур



c. 180 °C/W when mounted on a minimum pad of 2 oz copper



d. 145 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
- 3. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.

## Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted

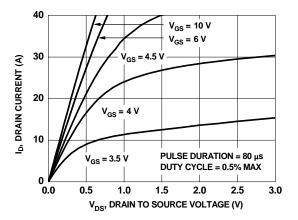


Figure 1. On Region Characteristics

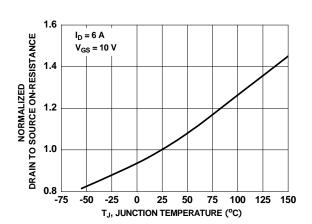


Figure 3. Normalized On Resistance vs Junction Temperature

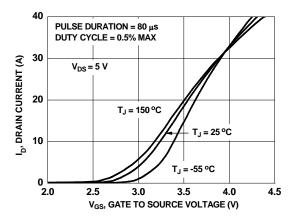


Figure 5. Transfer Characteristics

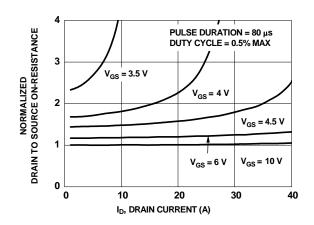


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

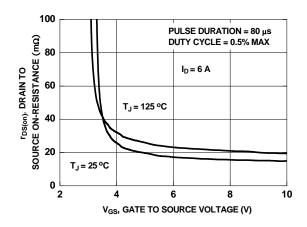


Figure 4. On-Resistance vs Gate to Source Voltage

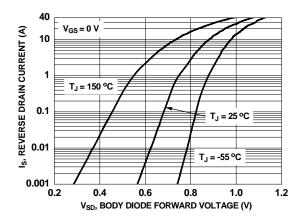


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

## Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted

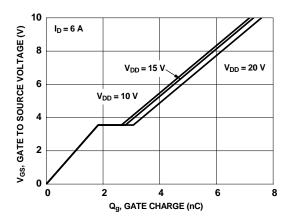


Figure 7. Gate Charge Characteristics

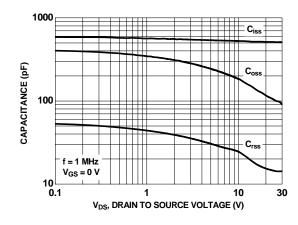


Figure 8. Capacitance vs Drain to Source Voltage

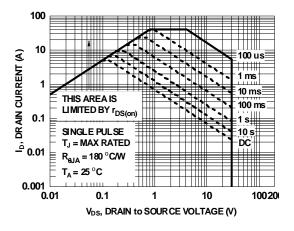


Figure 9. Forward Bias Safe Operating Area

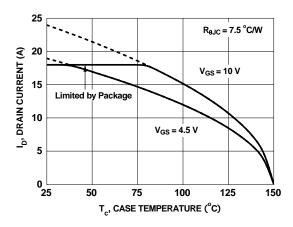


Figure 10. Maximum Continuous Drain Current vs Case Temperature

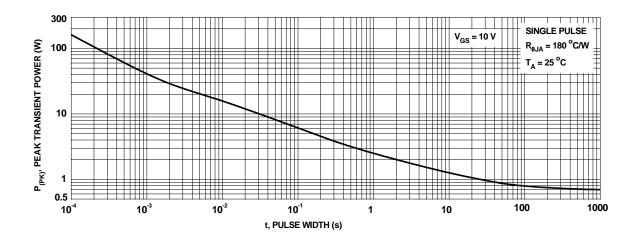


Figure 11. Single Pulse Maximum Power Dissipation

# Typical Characteristics (Q1 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted

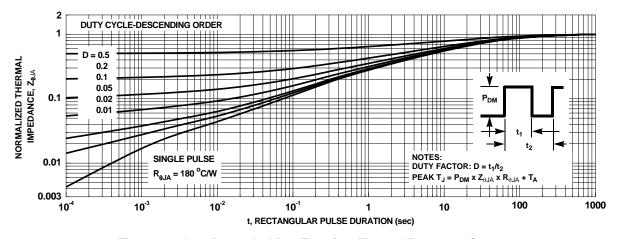


Figure 12. Junction-to-Ambient Transient Thermal Response Curve

# Typical Characteristics (Q2 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted

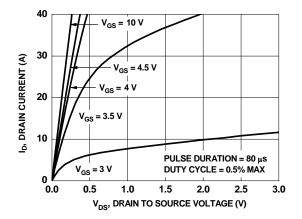


Figure 13. On-Region Characteristics

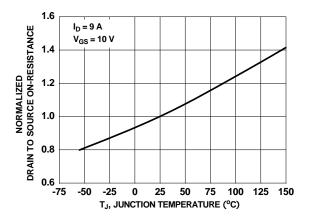


Figure 15. Normalized On-Resistance vs Junction Temperature

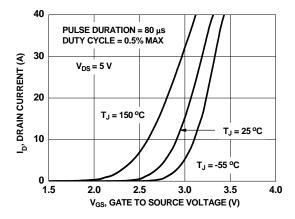


Figure 17. Transfer Characteristics

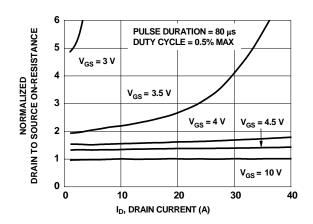


Figure 14. Normalized on-Resistance vs Drain Current and Gate Voltage

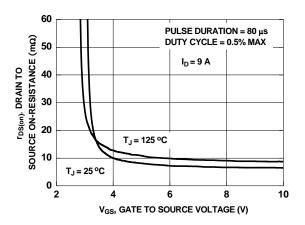


Figure 16. On-Resistance vs Gate to Source Voltage

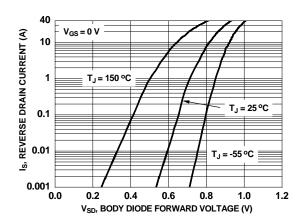


Figure 18. Source to Drain Diode Forward Voltage vs Source Current

# Typical Characteristics (Q2 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted

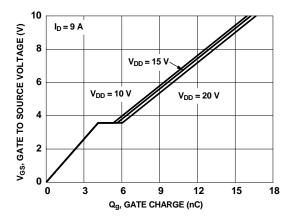


Figure 19. Gate Charge Characteristics

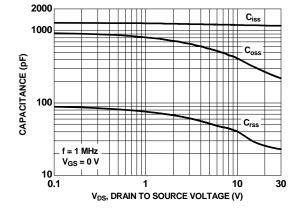


Figure 20. Capacitance vs Drain to Source Voltage

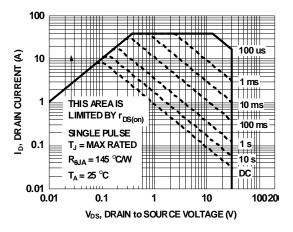


Figure 21. Forward Bias Safe Operating Area

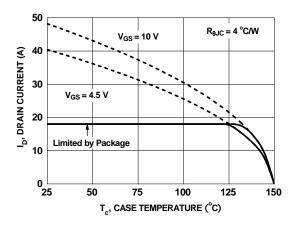


Figure 22. Maximum Continuous Drain Current vs Case Temperature

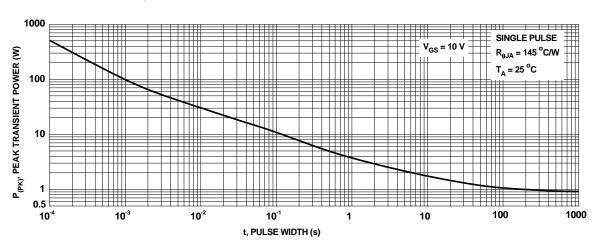


Figure 22. Single Pulse Maximum Power Dissipation

# Typical Characteristics (Q2 N-Channel) T<sub>J</sub> = 25 °C unless otherwise noted

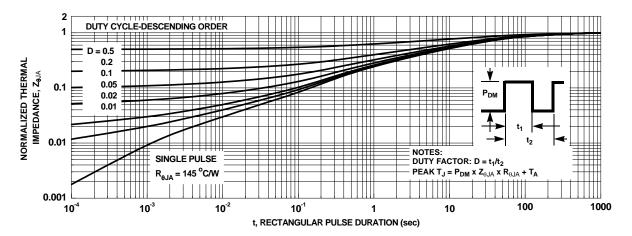
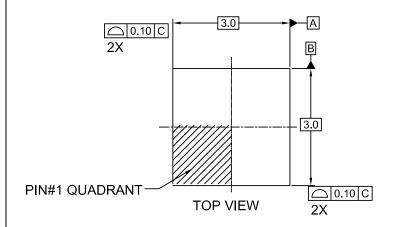
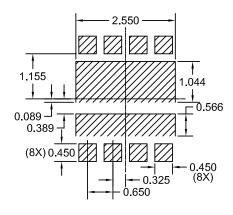


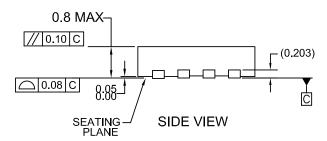
Figure 23. Junction-to-Ambient Transient Thermal Response Curve

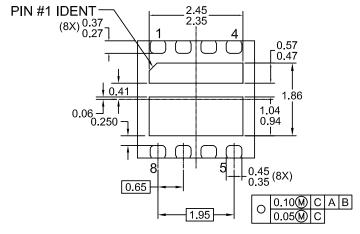
### **Dimensional Outline and Pad Layout**





RECOMMENDED LAND PATTERN





**BOTTOM VIEW** 

### NOTES:

- A. DOES NOT CONFORM TO JEDEC REGISTRATION MO-229
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994
- C. DRAWING FILE NAME: MLPO8NREVA

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Datasheet Identification	Product Status	Definition
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Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 168